Numerical Semiconductor Device Modeling EE614- Spring 08

Prof. Eric Polizzi

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Information

- Instructor: Prof. Eric Polizzi
- Office: Marcus 201C
- **Day and Time:** Tue-Thu 1:00-2:15
- Place: ELAB-325
- **Office Hours:** After class (up to 2:40pm), and Wed 11am-12
- E-mail: polizzi@ecs.umass.edu
- http://www.ecs.umass.edu/ece/polizzi
 - Go under Teaching and find also homework, and handouts.
- Homework (numerical) 40%, Final Project 40%, Final Report and Presentation 20%
- Account for Homework and Project:
 - explorer.ecs.umass.edu using your login id
 - ssh connection from linux/unix/windows/mac (free software)
 - Fortran 90/95, MPI, ...
- Prerequisite: 609 or equivalent

The Role of Computing in Science and Engineering

• **Goal:** Modeling and simulation (i.e. Computing) as the third component of science



Objectives of numerical device engineering (Computational Electronics)

- Supplement the past/current device R&D experimental cycle
- Is used to push the scaling limit of the MOS technology (investigates/predicts the ultimate size of MOS devices towards quantum effects and physical limitations)
- Is expected to lead the exploration of new class of devices that relies on quantum effects (nanoelectronics- high speed/Terahertz and high functionality devices)

EE614 – Overview/Approach

Our modeling & simulation framework is a process involving different steps.



Two difficulties:

(i) answering the questions above, multidisciplinary approach (ii) making links between communities, interdisciplinary activity

EE614 - Syllabus



Suggested Reading:

- Prof. T-W Tang notes, other courses on line (see website links)
- Brigitte Lucquin and Olivier Pironneau, 1998, Introduction to Scientific Computing, <u>Wiley</u>, 1998
- D. Vasileka, S. Goodnick, Computational Electronics, Morgan&Claypool publishers

Future of Computing



Figure from: Markus Püschel, CMU

Overview of Electronic Structure Calculations

 $(E - H(V)) \Psi_E = 0; + B.C.$ (Boundary Conditions)



Overview of Device Modeling



Current-Voltage Characteristics obtained by self-consistent simulations: Transport-Electrostatics

